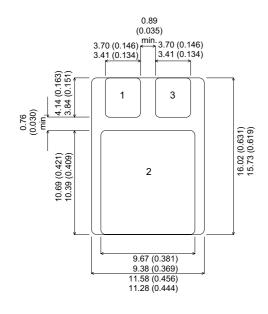
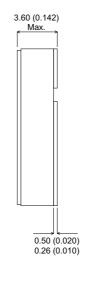


# IRFN9240SMD

### **MECHANICAL DATA**

Dimensions in mm (inches)





# P-CHANNEL POWER MOSFET

 $V_{DSS}$  -200V  $I_{D(cont)}$  -8A  $R_{DS(on)}$  0.051 $\Omega$ 

### **FEATURES**

- HERMETICALLY SEALED SURFACE MOUNT PACKAGE
- SMALL FOOTPRINT EFFICIENT USE OF PCB SPACE.
- SIMPLE DRIVE REQUIREMENTS
- LIGHTWEIGHT
- HIGH PACKING DENSITIES

### SMD1 PACKAGE

Pad 1 - Source

Pad 2 - Drain

Pad 3 – Gate

**Note:** IRFxxxSM also available with pins 1 and 3 reversed.

# **ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C unless otherwise stated)

$\overline{V_{GS}}$	Gate – Source Voltage	±20V		
I <sub>D</sub>	Continuous Drain Current (V <sub>GS</sub> = 0 , T <sub>case</sub> = 25°C)	–8.0A		
$I_D$	Continuous Drain Current (V <sub>GS</sub> = 0 , T <sub>case</sub> = 100°C)	–5.0A		
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	-32A		
$P_{D}$	Power Dissipation @ T <sub>case</sub> = 25°C	75W		
	Linear Derating Factor	0.6W/°C		
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>2</sup>	500mJ		
dv/dt	Peak Diode Recovery <sup>3</sup>	−5.5V/ns		
$T_J$ , $T_stg$	Operating and Storage Temperature Range	−55 to 150°C		
$T_L$	Package Mounting Surface Temperature (for 5 sec)	300°C		
$R_{ hetaJC}$	Thermal Resistance Junction to Case	1.67°C/W		
R <sub>θJ-PCB</sub>	Thermal Resistance Junction to PCB (Typical)	4°C/W		

#### **Notes**

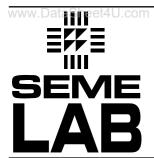
- 1) Pulse Test: Pulse Width  $\leq$  300ms,  $\delta \leq$  2%
- 2) @  $V_{DD}$  = –50V , L  $\geq$  11.7mH ,  $R_G$  =  $25\Omega$  , Peak  $I_L$  = –8A , Starting  $T_J$  =  $25^{\circ}C$
- 3) @  $I_{SD} \le -8A$ ,  $di/dt \le -150A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ ,  $T_J \le 150^{\circ}C$ , SUGGESTED  $R_G = 9.1\Omega$

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## IRFN9240SMD

# **ELECTRICAL CHARACTERISTICS** (T<sub>amb</sub> = 25°C unless otherwise stated)

	Parameter	Test Cond	itions	Min.	Тур.	Max.	Unit	
	STATIC ELECTRICAL RATINGS	1	•				, <b></b>	
BV <sub>DSS</sub>	Drain – Source Breakdown Voltage	$V_{GS} = 0$	$I_D = -1mA$	-200			V	
$\Delta BV_{DSS}$	Temperature Coefficient of	Reference to 25°C I <sub>D</sub> = -1mA			0.000	)	V/00	
$\Delta T_{J}$	Breakdown Voltage				-0.020		V/°C	
R <sub>DS(on)</sub>	Static Drain – Source On–State	$V_{GS} = -10V$	I <sub>D</sub> = -5A			0.51		
	Resistance <sup>1</sup>	$V_{GS} = -10V$	$I_D = -8A$			0.52	$ \Omega$	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = -250 \mu A$	-2		-4	V	
9 <sub>fs</sub>	Forward Transconductance <sup>1</sup>	V <sub>DS</sub> ≥ -15V	$I_{DS} = -5A$	4.0			S(\overline{O})	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0	$V_{DS} = 0.8BV_{DSS}$			-25	μΑ	
			T <sub>J</sub> = 125°C			-250		
I <sub>GSS</sub>	Forward Gate – Source Leakage	V <sub>GS</sub> = -20V				-100		
I <sub>GSS</sub>	Reverse Gate – Source Leakage V <sub>GS</sub> = 20V					100	nA	
	DYNAMIC CHARACTERISTICS						.1	
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0			1200			
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = -25V			570		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1MHz			81			
Qg	Total Gate Charge <sup>1</sup>	$V_{GS} = -10V$	I <sub>D</sub> = -8A	00				
		$V_{DS} = 0.5BV_{DS}$	V <sub>DSS</sub> 28		60	nC		
Q <sub>gs</sub>	Gate – Source Charge <sup>1</sup>	$I_D = -8A$ $V_{DS} = 0.5BV_{DSS}$		3.0		15	nC	
$Q_{gd}$	Gate - Drain ("Miller") Charge <sup>1</sup>			4.5		38		
t <sub>d(on)</sub>	Turn-On Delay Time	1001/			35	- ns		
t <sub>r</sub>	Rise Time	$V_{DD} = -100V$ $I_{D} = -8A$ $R_{G} = 9.1\Omega$					85	
t <sub>d(off)</sub>	Turn-Off Delay Time						85	
t <sub>f</sub>	Fall Time						65	
	SOURCE - DRAIN DIODE CHARAC	TERISTICS	<u> </u>					
I <sub>S</sub>	Continuous Source Current					-8		
I <sub>SM</sub>	Pulse Source Current <sup>2</sup>					-32	A	
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> = -8A	T <sub>J</sub> = 25°C			-4.6	V	
		$V_{GS} = 0$						
t <sub>rr</sub>	Reverse Recovery Time	$I_F = -8A$	· _			440	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	$d_i / d_t \le -100A/$	μs V <sub>DD</sub> ≤ -50V			7.2	μC	
t <sub>on</sub>	Forward Turn-On Time				negligible			
	PACKAGE CHARACTERISTICS							
L <sub>D</sub>	Internal Drain Inductance (from centre of drain pad to die)				0.8		nH	
L <sub>S</sub>	Internal Source Inductance (from centre	of source pad to end		2.8				

#### **Notes**

- 1) Pulse Test: Pulse Width  $\leq$  300ms,  $\delta \leq$  2%
- 2) Repetitive Rating Pulse width limited by maximum junction temperature.

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